

**Search Notes**

Application/Control No.

10/786,152

Examiner

Jason Benton

Applicant(s)/Patent under  
Reexamination

KOBAYASHI ET AL.

Art Unit

3747

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
123	21		
123	90.11		
123	Dig. 7		

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR